

<b>Notice of References Cited</b>	Application/Control No. 09/002,906	Applicant(s)/Patent Under Reexamination WUGOFSKI ET AL.	
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	B	US-5734589-	03-1998	Kostreski et al.	725	117
	C	US-6249320-	06-2001	Schneidewend et al.	725	56
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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